

<b>Notice of References Cited</b>	Application/Control No. 10/817,196	Applicant(s)/Patent Under Reexamination JAIN ET AL.	
	Examiner David Q. Nguyen	Art Unit 2681	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,144,653 A	11-2000	Persson et al.	370/337
	B	US-6,839,434 B1	01-2005	Mizikovsky, Semyon B.	380/247
	C	US-5,887,251 A	03-1999	Fehnel, Michael David	455/411
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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